

Test Report

EN 61000-6-1:2007

Electromagnetic Compatibility (EMC) - Part 6 - 1:Genetic Standards- Immunity for resident, commercial and light- industrial environments.

EN 61000-6-3:2007+A1:2011

Electromagnetic Compatibility (EMC) - Part 6 - 3 : Generic Standards – Emisson standard for residential, commercial and light – industrial environments.

Report Reference No:	C1L1310181592-E	
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(position+printed name+signature).:	Manager Jacky Chen	Jacky Chen
Date of issue:	October 23, 2013	34
Testing Laboratory Name:	Shenzhen CTL Electromagnetic Tec	chnology Co., Ltd.
Address::	Floor 1-A, Baisha Technology Park, N District, Shenzhen, China 518055	o.3011, Shahexi Road, Nanshan
Testing location/ procedure:	Full application of Harmonised standa Partial application of Harmonised stan Other standard testing methods	
Applicant's name:	Acrel Co.,Ltd.	O
Address::	No.253, YuLv Road, Jiading District, S	Shanghai, China
Test specification:		0
Standard:	EN 61000-6-1:2007 EN61000-6-3:2	007+A1:2011
Non-standard test method	25	
Test Report Form No	Ctra vic To	
TRF Originator:	Shenzhen CTL Electromagnetic Tech	nology Co., Ltd
Master TRF:	Dated 2013-06	
Shenzhen CTL Electromagnetic Tech	nology Co., Ltd.	
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Test item description: I	Electrical board for small and medium	size cold stroage
Manufacturer : A	Acrel Co., Ltd.	
Model No: [DDSD1352	
Listed Models : A	ADL100	
Trade Mark: /		
Ratings: A	AC 230V	
Result:: I	Positive	

V1.0 Page 2 of 35 Report No.: **CTL1310181592**-E

EMC -- Test Report

Test Report No. :	CTL1310181592-E	October 23, 2013
	C1L1310101392-L	Date of issue

Equipment under Test : Single-phase Electronic Meter

Type / Model : DDSD1352

Listed Models : ADL100

Applicant : Acrel Co., Ltd.

Address : No.253, YuLv Road, Jiading District, Shanghai, China

Manufacturer : Jiangsu Acrel Electric MFG.Co., Ltd.

Address : No.5 Dongmeng Road, Jiangyin City, Jiangsu Province, China

Test Result according to the standards on page 4:	Positive
7737	

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

Contents

1.	TEST STANDARDS
•	CLIMANA A DAV
2.	SUMMARY
2.1.	General Remarks:
2.2.	Equipment Under Test
2.3.	Short description of the Equipment under Test (EUT)
2.4.	EUT operation mode:
2.5.	EUT configuration:
2.6.	Performance Criteria
3.	TEST ENVIRONMENT
٠.	
3.1.	Address of the test laboratory
3.2.	Test Facility
3.3.	Environmental conditions
3.4.	Test Description
3.5.	Statement of the measurement uncertainty
3.6.	Equipments Used during the Test
	NX DECEMBER OF THE PROPERTY OF
4.	TEST CONDITIONS AND RESULTS1
4.	TEST CONDITIONS AND RESOLTS
4.1.	Radiated Emission 1
4.2.	Conducted disturbance 1
4.3.	Harmonic current 1
4.4.	Voltage Fluctuation and Flicker 1
4.5.	Electrostatic discharge 2
4.6.	Radiated, radio-frequency, electromagnetic field 2
4.7.	Electrical fast transients / Burst 2
4.8.	Surge 2
4.9.	Conducted disturbances induced by radio-frequency fields 3
4.10.	Magnetic Field Immunity 3
4.11.	Voltage Dips and Interruptions 3
	C/r
_	"Omagnetic
5.	Photos of the EUT

V1.0 Page 4 of 35 Report No.: **CTL1310181592**-E

1. TEST STANDARDS

The tests were performed according to following standards:

<u>EN 61000-6-1:2007</u> Electromagnetic Compatibility (EMC) - Part 6 - 1:Genetic Standards- Immunity for resident, commercial and light- industrial environments.

<u>EN 61000-6-3:2007+A1:2011</u> Electromagnetic Compatibility (EMC) - Part 6 - 3 : Generic Standards – Emisson standard for residential, commercial and light – industrial environments.



V1.0 Page 5 of 35 Report No.: CTL1310181592-E

2. SUMMARY

2.1. General Remarks:

Date of receipt of test sample : October 21, 2013

Testing commenced on : October 21, 2013

Testing concluded on : October 23, 2013

2.2. Equipment Under Test

Power supply system utilised

Power supply voltage : o 230V / 50 Hz o 115V / 60Hz

n Other (specified in blank below)

AC 230V

2.3. Short description of the Equipment under Test (EUT)

The EUT is a Single-phase Electronic Meter

Series number: prototype

2.4. EUT operation mode:

The equipment under test was operated during the measurement under the following conditions:

The tests are carried out with surge protective devices disconnected.

Test program (customer specific)

Immunity tests According to EN61000-6-1, searching for the highest susceptivity.

Harmonics current.....: According to EN 61000-3-2, searching for the highest disturbance.

Voltage fluctuation.....: According to EN 61000-3-3, searching for the highest disturbance.

V1.0 Page 6 of 35 Report No.: CTL1310181592-E

2.5. EUT configuration:

(The CDF filled by the applicant can be viewed at the test laboratory.)

The following peripheral devices and interface cables were connected during the measurement:

n- supplied by the manufacturer

o - supplied by the lab

2.6. Performance Criteria

Definition related to the performance level:

\boxtimes	based on the used product standard
	based on the declaration of the manufacturer, requestor or purchaser

Criterion A:

Definition: normal performance within limits specified by the manufacturer, requestor or purchaser:

The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Criterion B:

Definition: temporary loss of function or degradation of performance which ceases after the disturbance ceases, and from which the equipment under test recovers its normal performance, without operator intervention:

The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Criterion C:

Definition: temporary loss of function or degradation of performance, the correction of which requires operator intervention:

Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

V1.0 Page 7 of 35 Report No.: CTL1310181592-E

3. TEST ENVIRONMENT

3.1. Address of the test laboratory

Shenzhen CTL Electromagnetic Technology Co., Ltd. Floor 1-A, Baisha Technology Park, No. 3011, Shahexi Road, Nanshan, Shenzhen 518055 China

There is one 3m semi-anechoic chamber and two line conducted labs for final test. The Test Sites meet the requirements in documents ANSI C63.4 and CISPR 22/EN 55022 requirements.

3.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

IC Registration No.: 9618A

The 3m alternate test site of Shenzhen CTL Electromagnetic Technology Co., Ltd. EMC Laboratory has been registered by Certification and Engineer Bureau of Industry Canada for the performance of with Registration NO.: 9618A on May, 2011.

FCC-Registration No.: 807767

Shenzhen CTL Electromagnetic Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files, Registration 807767, June 27, 2011.

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3.3. Environmental conditions

During the measurement the environmental conditions were within the listed ranges

Temperature: 22-25 °C

Humidity: 40-54 %

Atmospheric pressure: 950-1050mbar

V1.0 Page 8 of 35 Report No.: CTL1310181592-E

3.4. Test Description

Emission Measurement		
Radiated Emission EN 61000-6-3:2007+A1:2011		PASS
Conduction Emission	EN 61000-6-3:2007+A1:2011	PASS
Harmonic Current	EN 61000-3-2: 2006+A2:2009	N/A
Voltage Fluctuation and Flicker	EN 61000-3-3: 2013	PASS
Immunity Measurement		
Electrostatic Discharge	EN 61000-6-1:2007	DACC
	IEC 61000-4-2: 2008	PASS
RF Field Strength Susceptibility	EN 61000-6-1:2007	PASS
	IEC 61000-4-3: 2006	
Electrical Fast Transient/Burst	EN 61000-6-1:2007	PASS
Test	IEC 61000-4-4: 2012	PASS
Surge Test	EN 61000-6-1:2007	PASS
1	IEC 61000-4-5: 2005	PASS
Conducted Susceptibility Test	EN 61000-6-1:2007	DASS
12, 1	IEC 61000-4-6: 2008	PASS
Power Frequency Magnetic Field	EN 61000-6-1:2007	PASS
Susceptibility Test	IEC 61000-4-8: 2009	FAOO
Voltage Dips and Interruptions	EN 61000-6-1:2007	PASS
Test	IEC 61000-4-11: 2004	PASS

Remark: The test result PASS and /or FAIL has no relationship with the measurement uncertainty.

3.5. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 "Specification for radio disturbance and immunity measuring apparatus and methods — Part 4: Uncertainty in EMC Measurements" and is documented in the Bontek Compliance Testing Laboratory Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for CTL laboratory is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	\pm 4.10dB	(1)
Radiated Emission	1~12.75GHz	\pm 4.32dB	(1)
Conducted Emission	0.15~30MHz	\pm 3.22dB	(1)

⁽¹⁾ This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.6. Equipments Used during the Test

Radia	Radiated Emission					
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	
1	ULTRA-BROADBAND ANTENNA	Sunol Sciences Corp.	JB1 Antenna	A061713	2013/04	
2	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESPI	1164.6407.07	2013/04	
3	RF TEST PANEL	ROHDE & SCHWARZ	TS / RSP	335015/ 0017	2013/04	
4	Controller	EM Electronics	Controller EM 1000	N/A	2013/04	
5	EMI TEST SOFTWARE	ROHDE & SCHWARZ	ESK1	N/A	2013/04	

Cond	ucted Emission				
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	1166.5950.03	2013/04
2	LISN	ROHDE & SCHWARZ	ENV216	101034	2013/04
4	EMI Test Software	ROHDE & SCHWARZ	ESK1	N/A	2013/04

Harm	Harmonic Current/ Voltage Fluctuation and Flicker						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.		
1	Purified Power Source	MToni	PHF 5010	8 N/A	2013/04		
2	Harmonic And Flicker Analyzer	Voltech	PM6000	8 N/A	2013/04		

Electr	rostatic Discharge	1	- Chi		
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	ESD Simulator	SKYLARK	ESD-2000	0220K10251	2013/04

RF Fi	RF Field Strength Susceptibility					
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	
1	S <mark>I</mark> GNAL GENERATOR	IFR	2032	203002/100	2013/04	
2	AMPLIFIER	AR	150W1000	301584	2013/04	
3	DUAL DIRECTIONAL COUPLER	AR	DC6080	301508	2013/04	
4	POWER HEAD	AR	PH2000	301193	2013/04	
5	POWER METER	AR	PM2002	302799	2013/04	

Electrical Fast Transient/Surge/Dips							
Item	Test Equipment		uipment Manufacturer Model No.		Serial No.	Last Cal.	
1	Ultra Simulator	Compact	HAEFELY	ECOMPACT4	174887	2013/04	

Conducted Susceptibility (CS):							
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.		
1	Conducted Disturbances test system	SCHLODER	CDG 6000	N/A	2013/04		
2	Amplifier	SCHLODER	4N100W-6DB	N/A	2013/04		
3	Dual Directional Coupler	AR	DC2600	302389	2013/04		
4	6db Attenuator	EMTEST	ATT6/75	0010230A	2013/04		
5	EM CLAMP	LÜTHI	EM101	335625	2013/04		
6	CDN	SCHLODER	CDN M2+M3	A2210225/2013	2013/04		

Powe	Power Frequency Magnetic Field Susceptibility								
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.				
1	ULTRA COMPACT SIMULATOR	EM TEST	UCS500M6	202304/060	2013/04				
2	MOTOR DRIVEN VOLTAGE TRANSFORMER	EM/TEST	MV2616	302205	2013/04				
3	CURRENT TRANSFORMER	EM TEST	MC2630	302389	2013/04				
4	MAGNETIC COIL	EM TEST	MS100	0010230A	2013/04				
	ectromagnetic Tech								

V1.0 Page 11 of 35 Report No.: CTL1310181592-E

4. TEST CONDITIONS AND RESULTS

4.1. Radiated Emission

For test instruments and accessories used see section 3.6.

4.1.1. Description of the test location

Test location: Shielded room No. 2

4.1.2. Limits of disturbance (EN61000-6-3)

Frequency (MHz)	Distance (Meters)	Field Strengths Limits (dBmV/m)
30 ~ 230	3	40
230 ~ 1000	3	47

Note: (1) The tighter limit shall apply at the edge between two frequency bands.

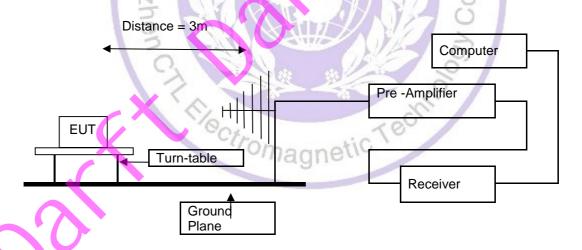
(2) Distance refers to the distance in meters between the test instrument antenna and the closest point of any part of the E.U.T.

4.1.3. Description of the test set-up

4.1.3.1. Operating Condition

The EUT is set to work shall be carried out with full load mode during the test, and the maximum emanating results are recorded.

4.1.3.2. Configuration of test setup



4.1.4. Test result

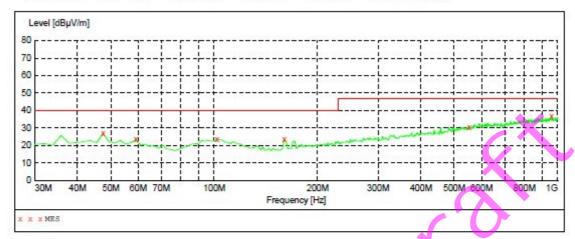
The requirements are Fulfilled

Band Width: 120KHz

Frequency Range: 30MHz to 1000MHz

Remarks: The limits are kept. For detailed results, please see the following page(s).

SWEEP TABLE: "test (30M-1G)"
Short Description: Field Strength Start Stop Detector Meas. Transducer Frequency Frequency 30.0 MHz 1.0 GHz Bandw. Time 100 kHz VULB9163 NEW Coupled



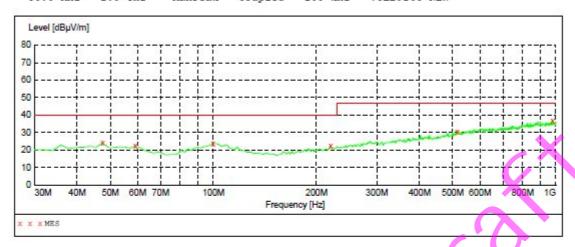
MEASUREMENT RESULT:

Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Det.	Height cm	Azimuth deg	Polarization
47.460000	27.10	15.8	40.0	12.9		100.0	0.00	
59.100000	23.50	14.6	40.0	16.5	_440	100.0	0.00	
101.780000	23.60	17.3	40.0	16.4		100.0	0.00	
159.980000	23.40	12.8	40.0	16.6		100.0	0.00	
551.860000	30.70	25.0	47.0	16.3	3.77.7	100.0	0.00	
959 260000	36 80	29 6	47.0	10.2		100.0	0.00	



SWEEP TABLE: "test (30M-1G)"
Short Description: Field Strength

Start Stop Detector Meas. IF Transducer Frequency Frequency Time Bandw.
30.0 MHz 1.0 GHz MaxPeak Coupled 100 kHz VULB9163 NEW



MEASUREMENT RESULT:

Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Det.	Height cm	Azimuth deg	Polarization	
47.460000	24.20	15.8	40.0	15.8	-4	100.0	0.00		
59.100000	22.50	14.6	40.0	17.5		100.0	0.00		
99.840000	24.00	17.5	40.0	16.0		100.0	0.00		
220.120000	22.50	15.3	40.0	17.5		100.0	0.00		
515.000000	30.80	24.2	47.0	16.2		100.0	0.00	T.T.T.	
978.660000	36.80	29.8	47.0	10.2		100.0	0.00		



V1.0 Page 14 of 35 Report No.: **CTL1310181592**-E

4.2. Conducted disturbance

For test instruments and accessories used see section 3.6.

4.2.1. Description of the test location

Test location: Shielded room No. 1

4.2.2. Limits of disturbance

Limit of disturbance voltage at the mains terminals

Fraguency Pango (MHz)	Limits	(dBuV)
Frequency Range (MHz)	Quasi-Peak	Average
0.150~0.500	66∼56	56∼46
0.500~5.000	56	46
5.000~30.00	60	50

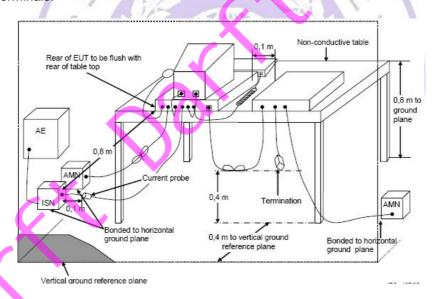
Note: (1) The tighter limit shall apply at the edge between two frequency bands.

4.2.3. Description of the test set-up

4.2.3.1. Operating Condition

The EUT is set to work shall be carried out full load mode during the test, and the maximum emanating results are recorded.

4.2.3.2. Configuration of test setup Mains terminals:



4.2.4. Test result

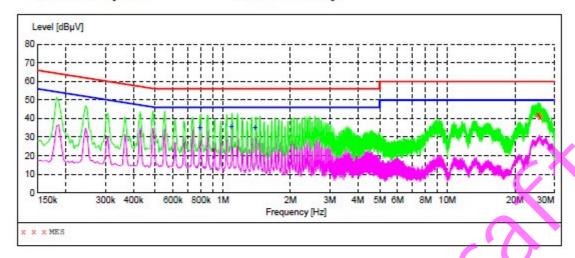
The requirements are Fulfilled

Band Width: 9KHz

Frequency Range: 150KHz to 30MHz

Remarks: The limits are kept. For detailed results, please see the following page(s).

SCAN TABLE: "Voltage (9K-30M)FIN"
Short Description: 150K-30M Voltage



MEASUREMENT RESULT:

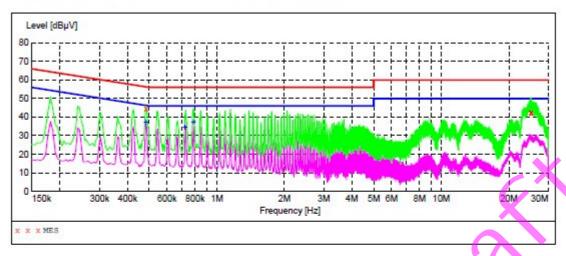
Frequency MHz	Level dBµV		Limit dBµV	Margin dB	Detector	Line	PE
25.381500	42.60	11.1	60	17.4	QP	Ll	GND
25.714500	41.80	11.1	60	18.2	QP	Ll	GND
25.881000	40.80	11.1	60	19.2	QP	L1	GND

MEASUREMENT RESULT:

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.789000	35.50	10.2	46	10.5	AV	Ll	GND
1.090500	35.90	10.3	46	10.1	AV	L1	GND
1.392000	35.10	10.3	46	10.9	AV	Ll	GND



SCAN TABLE: "Voltage (9K-30M)FIN"
Short Description: 150K-30M Voltage



MEASUREMENT RESULT:

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.483000	44.30	10.2	56	12.0	QP	N	GND
25.053000	42.20	11.1	60	17.8	QP	N	GND
25.161000	42.20	11.1	60	17.8	OP	N	GND

MEASUREMENT RESULT:

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.483000	37.80	10.2	46	8.5	AV	N	GND
0.721500	35.00	10.2	46	11.0	AV	N	GND
0.784500	37.60	10.2	46	8.4	AV	N	GND



V1.0 Page 17 of 35 Report No.: **CTL1310181592**-E

4.3. Harmonic current

For test instruments and accessories used see section 3.6.

4.3.1. Description of the test location

Test location: Shielded room No. 3

4.3.1. Limits of Harmonic Current

Test configuration and procedure see clause 7.1 of standard EN 61000-3-2: 2006+A2:2009.

4.3.2. Description of the test set-up

4.3.2.1. Operating Condition

The EUT is normal working mode during the test, and the maximum emanating results are recorded.

4.3.2.2. Test Configuration and Procedure

Test configuration and procedure see clause 6.2.2 and Appendix C of standard EN 61000-3-2: 2006+A1:2009.

4.3.3. Test result

N/A Not Applicable. The EUT power is less than 75w.



V1.0 Page 18 of 35 Report No.: **CTL1310181592**-E

4.4. Voltage Fluctuation and Flicker

For test instruments and accessories used see section 3.6.

4.4.1. Description of the test location

Test location: Shielded room No. 3

4.4.2. Limits of Voltage Fluctuation and Flicker

Test configuration and procedure see clause 5 of standard EN 61000-3-3: 2013.

4.4.3. Description of the test set-up

4.4.3.1. Operating Condition

The EUT is set to work shall be carried out with normal working mode during the test, and the maximum emanating results are recorded.

4.4.3.2. Configuration of test setup



4.4.4. Test result

The requirements are

Fulfilled

Remarks:

The limits are kept. For detailed results, please see the following page(s)

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Standard used: EN/IEC 61000-3-3 Flicker

Short time (Pst): 10 min

Observation time: 120 min (12 Flicker measurements)

Customer: Acrel Co.,Ltd..

Mains supply voltage: AC 230V

Ambient Temperature: 23° C Humidity: 51%

E. U. T.: Single-phase Electronic Meter

M/N: ADL100

Date of test: October 22, 2013

Tester: Ton

Test Result	PASS		•	
1 oot 1 toodit	17100			

Maximum Flicker results

/.	EUT values	Limit	Result
Pst /	0.028	1.00	PASS
Plt	0.028	0.65	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.127	4.00	PASS
dt [s]	0.000	0.50	PASS

Detail Flicker data

Flicker measurement 1	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.127	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 2	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.093	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 3	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.093	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 4	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.091	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 5	EUT values	Limit	Result
Pst / J	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.092	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 6	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.095	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 7	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.091	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 8	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.094	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 9	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.093	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 10	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.094	4.00	PASS
dt [s]	0.000	0.50	PASS

Flicker measurement 11	EUT values	Limit	Result
Pst /	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.095	4.00	PASS
dt [s]	0.000	0.50	PASS
nz	TEXT	4	

Flicker measurement 12	EUT values	Limit	Result
Pst	0.028	1.00	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.093	4.00	PASS
dt [s]	0.000	0.50	PASS

4.5. Electrostatic discharge

For test instruments and accessories used see section 3.6.

4.5.1. Description of the test location and date

Test location: Shielded room No. 3

Date of test: October 22, 2013

Operator: NADA

4.5.2. Severity levels of electrostatic discharge

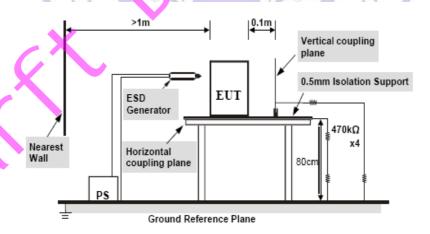
Level	Test Voltage	Test Voltage	
	Contact Discharge (KV)	Air Discharge (KV)	
1	2	2	
2	4	4	
3	6	8	
4	8	15	
Х	Special	Special	

4.5.3. Description of the test set-up

4.5.3.1. Operating Condition

The EUT is set to work shall be carried out with normal working mode during the test, and the maximum emanating results are recorded.

4.5.3.2. Configuration of test setup



V1.0 Page 23 of 35 Report No.: **CTL1310181592-**E

4.5.4. Test specification:

Contact discharge voltage: n 2 kV n 4 kV

Air discharge voltage: n 2 kV n 4 kV n 8 kV

Number of discharges: $\square \ge 10$ $n \ge 25$

Type of discharge:

Direct discharge

n Air discharge

n Contact discharge

Indirect discharge n Contact discharge

Polarity: n Positive n Negative

<u>Discharge location:</u> **n** see photo documentation of the test set-up

n all external locations accessible by hand

n horizontal plate (HCP)

n vertical coupling plate (VCP)

omagnetic Techno

4.5.5. Test result

The requirements are **Fulfilled**Performance Criterion: **B**

V1.0 Page 24 of 35 Report No.: CTL1310181592-E

4.6. Radiated, radio-frequency, electromagnetic field

For test instruments and accessories used see section 3.6.

4.6.1. Description of the test location and date

Test location: Shielded room No. 2

Date of test: October 22, 2013

Operator: Bove

4.6.2. Severity levels of radiated, radio-frequency, electromagnetic field

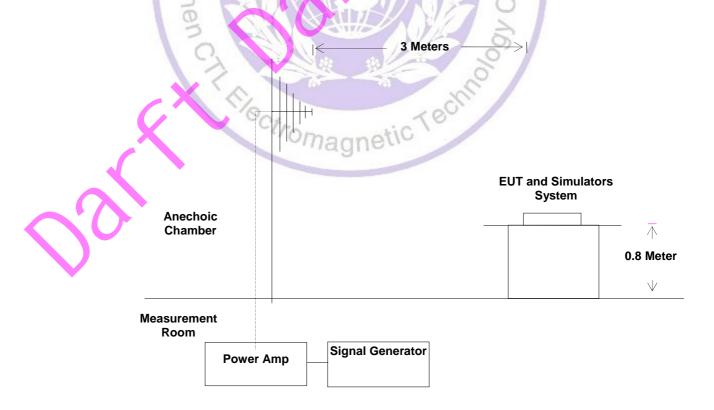
Level	Field Strength (V/m)		
1.	1		
2.	3		
3.	10		
X	Special		

4.6.3. Description of the test set-up

4.6.3.1. Operating Condition

The EUT is set to work shall be carried out normal working mode during the test, and the maximum emanating results are recorded.

4.6.3.2. Configuration of test setup



4.6.4. Test specification:

Frequency range: n 80 MHz to 1000 MHz

Field strength: n 3 V/m

EUT - antenna separation: n 3 m

Modulation: n AM: 80 %

n sinusoidal 1000Hz

Frequency step: n 1 % with 3 s dwell time

Antenna polarisation: n horizontal n vertical

4.6.5. Test result

The requirements are **Fulfilled**Performance Criterion: A



4.7. Electrical fast transients / Burst

For test instruments and accessories used see section 3.6.

4.7.1. Description of the test location

Test location: Shielded room No. 3

Date of test: October 22, 2013

Operator: Tony

4.7.2. Severity levels of electrical fast transients / Burst

Severity level: $\pm 1000 \text{V}$ for AC power supply lines

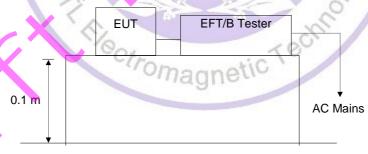
	Open Circuit Output Test Voltage ±10%				
	For Powe	r Supply Lines	For I / O (Input / Output) Signal Data and Control Lines		
Level	V peak(KV)	Repetition Frequency (KHz)	V peak(KV)	Repetition Frequency (KHz)	
1	0.5	5 or 100	0.25	5 or 100	
2	1	5 or 100	0.5	5 or 100	
3	2	5 or 100	1	5 or 100	
4	4	5 or 100	2	5 or 100	
Х	Special	Special	Special	Special	

4.7.3. Description of the test set-up

4.7.3.1. Operating Condition

The EUT is set to work shall be carried out with normal working mode during the test, and the maximum emanating results are recorded.

4.7.3.2. Configuration of test setup



4.7.4. Test specification:

Coupling network:n 0.5 kVn 1 kV2 kVCoupling clamp:0.5 kV1 kV2 kV

Burst frequency: n 5.0 kHz

Coupling duration: $n \ge 60 \text{ s}$

Polarity: n positive n negative

V1.0 Page 27 of 35 Report No.: **CTL1310181592-**E

4.7.5. Coupling points

Cable description: AC power line : L, N, L+N

Screening: o screened n unscreened Status: o passive n active Signal transmission: n analogue o digital

Length: n 1.5 m

4.7.6. Test result

The requirements are **Fulfilled** Performance Criterion: **B**



4.8. Surge

For test instruments and accessories used see section 3.6.

4.8.1. Description of the test location

Test location: Test location No. 3

Date of test: October 22, 2013

Operator: Andy

4.8.2. Severity levels of surge

Level	Test Voltage (KV)
1	0.5
2	1.0
3	2.0
4	4.0
*	Special

4.8.3. Description of the test set-up

4.8.3.1. Operating Condition

The EUT is set to work shall be carried out normal working mode during the test, and the maximum emanating results are recorded.

4.8.3.2. Configuration of test setup



4.8.4. Test specification:

Pulse amplitude-Power line sym.: Source impedance: $2 \Omega + 18\mu F$	n 0.5 kV	n 1 kV	□ 2 kV	□ 4 kV
Pulse amplitude-Power line un sym: Source impedance: 12 Ω + 9μF	n 0.5 kV	n 1 kV	□ 2 kV	□ 4 kV
Signal line:	□ 0.5 kV	□ 1 kV	□ 2 kV	□ 4 kV
Number of surges:	n 5 Surges	s/Phase angl	е	
Phase angle:	n 0°	n 90 °	n 180°	n 270 °
Repetition rate:	n 60 s			
Polarity:	n positive		n negativ	е

V1.0 Page 29 of 35 Report No.: **CTL1310181592-**E

4.8.5. Coupling points

Cable description: AC power line: L+N

Screening: o screened n unscreened Status: o passive n active Signal transmission: n analogue o digital

Length: n 1.5 m

4.8.6. Test result

The requirements are **Fulfilled** Performance Criterion: **B**



V1.0 Page 30 of 35 Report No.: **CTL1310181592-**E

4.9. Conducted disturbances induced by radio-frequency fields

For test instruments and accessories used see section 3.6.

4.9.1. Description of the test location

Test location: Shielded room No. 3

Date of test: October 22, 2013

Operator: Andy

4.9.2. Severity levels of conducted disturbances

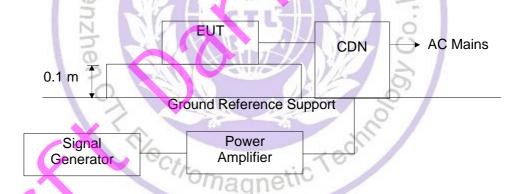
Level	Field Strength (V)
1.	1
2.	3
3.	10
Х	Special

4.9.3. Description of the test set-up

4.9.3.1. Operating Condition

The EUT is set to work shall be carried out with normal working mode during the test, and the maximum emanating results are recorded.

4.9.3.2. Configuration of test setup



4.9.4. Test specification:

Frequency range: n 0.15 MHz to 80 MHz

Test voltage: n 3 V

Modulation: n AM: 80 %

n sinusoidal 1000Hz

Frequency step: n 1 % with 3 s dwell time

4.9.5. Coupling points

Cable description AC power line

Screening:

Status:

o passive

n unscreened

n active

n analogue

o digital

Length: n 1.5 m

V1.0 Page 31 of 35 Report No.: **CTL1310181592-**E

4.9.6. Test result

The requirements are **Fulfilled** Performance Criterion: **A**



V1.0 Page 32 of 35 Report No.: CTL1310181592-E

4.10. Magnetic Field Immunity

For test instruments and accessories used see section 3.6.

4.10.1. Description of the test location

Shielded room No.3 Test location:

Date of test: October 22, 2013

Operator: Andy

4.10.2. Severity levels of magnetic field immunity

Level	Magnetic Field Strength (A/m)		
1	1		
2	3		
3	10		
4	30		
5	100		
X.	Special		

4.10.3. Description of the test set-up

4.10.3.1. Operating Condition

The EUT is set to work shall be carried out normal working mode during the test, and the maximum emanating results are recorded.

4.10.4. Test specification:

Test frequency: n 50 Hz

n 1 A/m Continuous field:

Test duration:

Antenna factor:

n x-axis Axis: n y-axis n z-axis

4.10.5. Test result

The requirements are Fulfilled Performance Criterion: A

V1.0 Page 33 of 35 Report No.: **CTL1310181592**-E

4.11. Voltage Dips and Interruptions

For test instruments and accessories used see section 3.6.

4.11.1. Description of the test location

Test location: Test location No. 3

Date of test: October 22, 2013

Operator: NADA

4.11.2. Severity levels of electrostatic discharge

Test Level (%Ut)	Voltage Dip And Short Interruptions (%Ut)	Performance Criterion	Duration (in Period)
0	100	В	0.5
0	100	С	250
70	30	С	25

4.11.3. Description of the test set-up

4.11.3.1. Operating Condition

The EUT is set to work shall be carried out normal working mode during the test, and the maximum emanating results are recorded.

4.11.3.2. Configuration of test setup



4.11.4. Test specification:

Nominal Mains Voltage (V_N). n 230 V AC

Number of voltage fluctuations: n 3

Level of reduction(dip) / duration: n 100 % / 10ms n 30 % / 500ms

Nominal Mains Voltage (V_N): n 230 V AC

Number of Interruptions: n 3

<u>Duration of the Interruption</u>: **n** 5000 ms

4.11.5. Test result

The requirements are **Fulfilled**Performance Criterion **See section 4.11.2**